Search Notes

Application/Control No.	Applicant(s)/Patent under R xamination
10/751,312	SCHOTTLER ET AL.
Examiner	Art Unit
Sunray Chang	2121

SEARCHED					
Class	Subclass	Date	Examiner		
91	361	1/15/2006	sc		
381	94.3	1/15/2006	sc		
381	71.14	1/15/2006	sc		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
-	l			

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	1/16/2006	sc
EAST (USPAT, US_PGPUB, JPO, EPO, DERWENT, IBM_TDB)	6/7/2006	sc